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- > <u>Certifications, evaluations and standards</u>
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CLAS Certificate Number 2003-05

Company name	Mitutoyo Canada Inc. Calibration Laboratory
Company address	2121 Meadowvale Mississauga, Ontario L5N 5N1
Contact	Gary Mueller Telephone: 905-821-1261 Fax: 905-821-4968 Email: gary.mueller@mitutoyo.ca
Clients served	 All interested parties On-site calibration services are available for the capabilities for which it is indicated in the remarks column.

Fields of calibration	DimensionalMechanical
SCC accreditation (ISO/IEC 17025)	 SCC file number: 15587 First issued 2003-10-07 Issue 8.3e 2023-05-02

This CLAS Certificate is published by the CLAS program of the National Research Council of Canada (NRC) in cooperation with the laboratory accreditation program of the Standards Council of Canada (SCC), Canada's accreditation body for calibration and testing laboratories. The SCC accredits the capability of the named laboratory for being able to perform calibrations as per the listed Calibration and Measurement Capabilities with metrological traceability to the International System of Units (SI) or to standards acceptable to the CLAS program. See supplementary notes.

Measured Quantity & Range or Instrument	Expanded Measurement Uncertainty	Type of Service	Remarks
Gauge block CL See note ¹	.TM-7		
Steel, length			

Measured Quantity & Range or Instrument	Expanded Measurement Uncertainty	Type of Service	Remarks
Inch, up to 4 inches	(1.6 + 0.8 L) µinch (L in inches) or 2 µinch, whichever greater	I	Using automatic comparator
Metric, up to 100 mm	(0.041+ 0.0008 L) µm (L in mm) or 0.05 µm, whichever greater		Using automatic comparator
Inch, up to 1 inch	(4 + 0.7 L) µinch (L in inches)		Using manual comparator; direct comparison
Metric, up to 25 mm	(0.11+ 0.0007 L) µm (L in mm)		Using manual comparator; direct comparison

Measured Quantity & Range or Instrument	Expanded Measurement Uncertainty	Type of Service	Remarks
Inch, up to 1 inch	(7+ 0.7 L) μinch (L in inches)		Using manual comparator; wide-range
Metric, up to 25 mm	(0.18+ 0.0007 L) µm (L in mm)		Using manual comparator; wide-range
Inch, 1 inch to 10 inches	(5 + 5.5 L) µinch (L in inches)		Using manual comparator; direct comparison
Metric, 25 mm to 250 mm	(0.13+ 0.0055 L) µm (L in mm)		Using manual comparator; direct comparison
Inch, 12 inches to 20 inches	47 μinch		Using CMM

Measured Quantity & Range or Instrument	Expanded Measurement Uncertainty	Type of Service	Remarks
Metric, 300 mm to 500 mm	1.2 µm		Using CMM
Ceramic, length See note ¹			
Inch, up to 4 inches	(1.6+ 0.7 L) µinch (L in inches) or 2 µinch, whichever greater	I	Using automatic comparator
Metric, up to 100 mm	(0.04+ 0.0007 L) µm (L in mm) or 0.05 µm, whichever greater		Using automatic comparator
Gauge Block See note ²			

Measured Quantity & Range or Instrument	Expanded Measurement Uncertainty	Type of Service	Remarks
Variation in length (parallelism)	1 μinch or 0.025 μm	I	Using automatic comparator
Height gauge			
Inch, up to 40 inches	(51+ 2.0 L) µinch (L in inches)	II	See note ³
Metric, up to 1000 mm	(1.3+ 0.002 L) µm (L in mm)		
Micrometer			
Head			
Inch, up to 2 inches	30 μinch	II	See note ³
Metric, up to 50 mm	0.6 μm		
Outside			

Measured Quantity & Range or Instrument	Expanded Measurement Uncertainty	Type of Service	Remarks
Inch, up to 6 inches	(45 + 2 L) µinch (L in inches)	II	See note ³
Inch, > 6 inches to 20 inches	(50 + 4.2 L) µinch (L in inches)		
Metric, up to 500 mm	(1.0 + 0.0042 L) µm (L in mm)		
Depth			
Inch, up to 6 inches	(45 + 2.2 L) µinch (L in inches)	II	See note 3
Inch, > 6 inches to 12 inches	(55 + 3.8 L) µinch (L in inches)		
Metric, up to 300 mm	(1.1 + 0.0036 L) µm (L in mm)		
Tubular inside		1	1

Measured Quantity & Range or Instrument	Expanded Measurement Uncertainty	Type of Service	Remarks
Inch, up to 2 inches	(50 + 0.8 L) µinch (L in inches)	II	See note ³
Inch, > 2 inches to 24 inches	(60 + 4.4 L) µinch (L in inches)		
Metric, up to 600 mm	(1.0 + 0.005 L) µm (L in mm)		
Three point interr	nal		
Inch, up to 7 inches	(75 + 1.6 L) µinch (L in inches)	II	See note 3
Metric, up to 175 mm	(1.3 + 0.0032 L) µm (L in mm)		
Indicator tester		,	

Measured Quantity & Range or Instrument	Expanded Measurement Uncertainty	Type of Service	Remarks
Inch, up to 1 inch	30 µinch	II	See note ³
Metric, up to 25 mm	0.6 μm		
Bore gauge (2 poi	nts)		
Inch, up to 4 inches	(50 + 0.3 L) µinch (L in inches)	II	See note ³
Metric, up to 100 mm	(1.1 + 0.0006 L) µm (L in mm)		
Indicator			
Dial			

Measured Quantity & Range or Instrument	Expanded Measurement Uncertainty	Type of Service	Remarks
Inch, 0.00005 inch graduations	14 µinch	II	Up to 4 inch travel
Inch, 0.0001 inch graduations	20 μinch		
Metric, 0.001 mm graduations	0.3 μm		Up to 100 mm travel
Metric, 0.002 mm graduations	0.4 μm		
Metric, 0.02 mm graduations	3.0 µm		
Digital		ı	

Measured Quantity & Range or Instrument	Expanded Measurement Uncertainty	Type of Service	Remarks	
Inch, 0.00005 inch resolution	30 µinch	II	Up to 4 inch travel	
Metric, 0.0005 mm resolution	0.4 μm		Up to 100 mm travel	
Metric, 0.001 mm resolution	0.7 μm			
Metric, 0.01 mm resolution	5.8 µm			
Caliper				
Outside, Inside an	d Depth			
Inch				
up to 24 inches	(290 + 1.6 L) µinch (L in inches)	II	See note ¹	
> 24 inches to 40 ii	nches			

Measured Quantity & Range or Instrument	Expanded Measurement Uncertainty	Type of Service	Remarks
0.0005 inch resolution	(400 + 14 L) µinch (L in inches)	II	See note ¹
0.001 inch resolution	(1000 + 10 L) µinch (L in inches)		
Metric			
up to 600 mm	(5.8 + 0.002 L) µm (L in mm)	II	See note ¹
> 600 mm to 1000	mm		
0.01 mm resolution	(7.5 + 0.014 L) μm (L in mm)	II	See note ¹
0.02 mm resolution	(20 + 0.010 L) µm (L in mm)		
Depth gauge			
Dial Caliper Type			

Measured Quantity & Range or Instrument	Expanded Measurement Uncertainty	Type of Service	Remarks
Inch, up to 12 inches	0.0024 inch	II	See note ³
Metric, up to 300 mm	60 µm		
Dial Indicator Typ	е		
Inch, up to 12 inches	580 µinch	II	See note ³
Metric, up to 300 mm	12 μm		
Digital Caliper Typ	oe .		
Inch, up to 12 inches	290 μinch	II	See note ³
Metric, up to 300 mm	6 µm		
Digital Indicator Type			

Measured Quantity & Range or Instrument	Expanded Measurement Uncertainty	Type of Service	Remarks	
Inch, up to 12 inches	(30 + 2 L) µinch (L in inches)	II	See note ³	
Metric, up to 300 mm	(0.6 + 0.0025 L) µm (L in mm)			
Vernier Caliper Ty	pe			
Inch, up to 12 inches	1200 μinch	II	See note ³	
Metric, up to 300 mm	24 μm			
External caliper gauge				
Inch, up to 4 inches				

Measured Quantity & Range or Instrument	Expanded Measurement Uncertainty	Type of Service	Remarks	
0.0002 inch resolution	120 µinch	II	See note ¹	
0.0005 inch resolution	290 μinch			
0.001 inch resolution	580 μinch			
0.002 inch resolution	1200 μinch			
0.005 inch resolution	2900 μinch			
Metric, up to 100 mm				

Measured Quantity & Range or Instrument	Expanded Measurement Uncertainty	Type of Service	Remarks	
0.005 mm resolution	2.9 µm	II	See note ¹	
0.01 mm resolution	5.8 µm			
0.02 mm resolution	12 µm			
0.05 mm resolution	29 µm			
0.1 mm resolution	58 μm			
Internal caliper gauge				
Inch, up to 4 inches				

Measured Quantity & Range or Instrument	Expanded Measurement Uncertainty	Type of Service	Remarks
0.0002 inch resolution	120 µinch	II	See note ¹
0.0005 inch resolution	290 μinch		
0.001 inch resolution	580 μinch		
Metric, up to 100 r	nm		
0.005 mm resolution	2.9 µm	II	See note ¹
0.01 mm resolution	5.8 µm		
0.02 mm resolution	12 µm		
Thickness gauge			

Measured Quantity & Range or Instrument	Expanded Measurement Uncertainty	Type of Service	Remarks
Inch, up to 1 inch	290 µinch	II	See note ³
Metric, up to 25 mm	5.8 µm		
Profile projector			

Measured Quantity & Range or Instrument	Expanded Measurement Uncertainty	Type of Service	Remarks	
Linearity of movement: Digital readout type	(1.6 + 0.021 L) µm (L in mm)	III	See note ³ On-site calibration available.	
Linearity of movement: Micrometer head type	(1.6 + 0.017 L) µm (L in mm)			
Magnification error	(13+0.017 L) µm (L in mm)			
Squareness of stage	0.7 μm			
Eccentricity of screen rotation	1.6 µm			
Parallelism of stage	1.7 µm			

Measured Quantity & Range or Instrument	Expanded Measurement Uncertainty	Type of Service	Remarks
Accuracy of edge finder	1.0 µm		
I-Checker			
0 mm to 100 mm	(0.13 +. 0027 L) µm , L is in mm	II	See note ¹
0 inches to 4 inches	(5.1 + 2.7 L) µinch, L is in inch		
Mu-checker: Graduation			

Measured Quantity & Range or Instrument	Expanded Measurement Uncertainty	Type of Service	Remarks
0.1 μm	0.3 µm	II	See note ¹
0.5 μm	0.3 µm		
1 μm	0.4 μm		
5 μm	1.5 µm		
10 μm	2.9 µm		
50 μm	15 µm		
0.000005 inch	10 μinch		
0.00001 inch	10 μinch		
0.00005 inch	17 μinch		
0.0001 inch	30 µinch		
0.0005 inch	150 μinch		
0.001 inch	290 μinch		
Riser block			

Measured Quantity & Range or Instrument	Expanded Measurement Uncertainty	Type of Service	Remarks	
150 mm to 600 mm	(0.4 + 0.002 L) µm , L is in mm	II	See note ¹	
6 inches to 24 inches	(16 + 2 L) µinch , L is in inch			
Height masters				
Up to 300 mm	(0.5 + 0.002 L) µm , L is in mm	II	See note ¹	
Up to 12 inches	(20 + 2 L) µinch , L is in inch			
Step gauge (checkmaster)				

Measured Quantity & Range or Instrument	Expanded Measurement Uncertainty	Type of Service	Remarks	
Up to 1010 mm	(0.39 + 0.0014 L) µm where L is the length in mm	II	See note 13	
> 1010 mm to 1710 mm	(0.61 + 0.0018 L) µm where L is the length in mm			
Up to 40 inch	(15.4 + 1.4 L) µinch where L is the length in inches			
> 40 Inch up to 70 Inch	(24 + 1.8 L) µinch where L is the length in inches			
Micrometer standard				

Measured Quantity & Range or Instrument	Expanded Measurement Uncertainty	Type of Service	Remarks
5 mm to 500 mm	(0.32 + 0.002 L) µm where L is the length in mm	II	See note ¹³
> 500 mm to 1000 mm	(0.69 + 0.004 L) µm where L is the length in mm		
0.2 inches to 20 inches	(12.6 + 2 L) µinch where L is the length in inches		
> 20 inches to 40 inches	(27.2 + 4 L) µinch where L is the length in inches		

Flatness

for granite or steel surfaces requiring an accuracy of greater than 0.4 μm

Measured Quantity & Range or Instrument	Expanded Measurement Uncertainty	Type of Service	Remarks	
1 mm x 1 mm to 900 mm x 1000 mm	(0.34 + 0.002 L) µm where L is the maximum length in mm	II	See note 15	
0.04 inches x 0.04 inches to 35 inches x 40 inches	(13 + 2 L) µinch where L is the maximum length in inches			
Cylindrical ring ga	uge: Diameter			
3 mm to 500 mm	(0.46 + 0.002D) μm where D is the diameter in mm	II	See note 13	
0.12 inches to 20 inches	(18.1 + 2.0D) µinch where D is the diameter in inches			
Cylindrical plug gauges: Diameter				

Measured Quantity & Range or Instrument	Expanded Measurement Uncertainty	Type of Service	Remarks
3 mm to 500 mm	(0.30 + 0.002D) μm where D is the diameter in mm	II	See note 13
0.12 inches to 20 inches	(11.8 + 2.0D) µinch where D is the diameter in inches		
Test spheres			
Diameter			
8 mm to 50 mm	0.4 μm	II	See note 13
0.3 inches to 2 inches	16 µinch		
Form			

Measured Quantity & Range or Instrument	Expanded Measurement Uncertainty	Type of Service	Remarks
8 mm to 50 mm	(0.05 + 0.007R) µm where R is the measured roundness in µm	II	See note 14
0.3 inches to 2 inches	(2.0 + 0.007R) µinch where R is the measured roundness in µinch		
Roundness			
Diameter of 2 mm to 200 mm	(0.05 + 0.007R) µm where R is the measured roundness in µm	II	See note ¹⁴
Diameter of 0.8 inches to 8 inches	(2.0 + 0.007R) µinch where R is the measured roundness in µinch		

Measured Quantity & Range or Instrument	Expanded Measurement Uncertainty	Type of Service	Remarks
Precision squares			
50 mm to 800 mm	(0.3 + 0.003 L) µm where L is the length in mm	II	See note 15
2 inches to 32 inches	(12 + 3 L) µinch where L is the length in inches		
Parallels: Granite	or steel		
5 mm to 1000 mm			
Parallelism	(0.33 + 0.002 L) µm where L is the length in mm	II	See note ¹³
Width	(0.83 + 0.001 L) µm where L is the length in mm		
0.2 inches to 40 inches			

Measured Quantity & Range or Instrument	Expanded Measurement Uncertainty	Type of Service	Remarks	
Parallelism	(13.0 + 2 L) µinch where L is the length in inches	II	See note ¹³	
Width	(32.7 + 1.0 L) µinch where L is the length in inches			
Mitutoyo contracer and form tracers				
Up to 200 mm Horizontal Axis:				

Measured Quantity & Range or Instrument	Expanded Measurement Uncertainty	Type of Service	Remarks	
Measurement of Stylus Radius	(1.21 + 0.004D) µm where D is measured Radius length in mm	III	On-site services as per FSTM-11	
Detector Accuracy	(0.33 + 0.0007L) µm where L is the length in mm			
X and Y Axis	(0.63 + 0.004L) µm where L is measurement length in mm			
Straightness	0.09 µm			
Surface roughness	0.07 μm			
Coordinate measuring machines (CMM)				

Measured Quantity & Range or Instrument	Expanded Measurement Uncertainty	Type of Service	Remarks	
		On-site services as per ISO 10360-2 2009 edition and 2001 edition.		
Error of Indication	1			
0 m to 1.5 m	(0.12 + 0.00004 L) µm where L is the length in mm	III	See note 10	
0 m to 40 m	(0.16 + 0.0006 L) µm where L is the length in mm		See note ¹¹	
Probing Error				
10 mm to 50 mm in sphere diameter	0.14 μm	III	See note 12	

Measured Quantity & Range or Instrument	Expanded Measurement Uncertainty	Type of Service	Remarks
Mitutoyo optic co	oordinate measuring mach	nines	
Up to 600 mm			
Length Measurement Error: E _{UXY}	(0.25 + 0.39 x L/1000) µm at <i>k</i> =2 where L is measured Length in mm	III	On-site services according to ISO 10360-7: 2011 and FSTM-8
Length Measurement Error: E _{UZ}	(0.27 + 0.60 x L/1000) µm at <i>k</i> =2 where L is measured Length in mm		See note ¹⁷ See note ¹⁸
Squareness Error: E _{sQ}	(1.79 + 0.003L) µm at k=2 where L is measured Length in mm		
Probing Error: P _{F2D}	0.13 μm		
Probing Error: P _{FV2D}	0.13 μm		

Measured Quantity & Range or Instrument	Expanded Measurement Uncertainty	Type of Service	Remarks		
Surface roughnes	S				
R _a up to 4.1 μm					
R _a	0.07 µm	II	See note 16		
R _{max} , R _y	0.29 µm				
R _a up to 160 µinch	R _a up to 160 μinches				
R _a	3 µinches	II	See note ¹⁶		
R _{max} , R _y	11 µinches				
Precision Glass Sc	ales				
0 mm to 400 mm	(1.4 + 0.011L) µm, where L is Length in mm	II	See note 19		
0 inches to 15.7 inches	(55.2 + 11L) µinches, where L is Length in inches				
Precision Rulers					

Measured Quantity & Range or Instrument	Expanded Measurement Uncertainty	Type of Service	Remarks
0 mm to 400 mm	(4.3 + 0.012L) μm, where L is Length in mm	II	See note 19
0 inches to 15.7 inches	(169 + 12L) µinches, where L is Length in inches		
Hardness			
Indirect verification	on of Rockwell hardness t	esters	
HRA	Governed by the uncertainty of the	III	ASTM E18 Standardized Test
HRB	standardized test block used to perform the		Blocks per ASTM E18
HRC	indirect verification		See notes $\frac{4}{7}$ and $\frac{8}{7}$.
HRD			On-site
HRE			calibration available.
Indirect verification of Rockwell Superficial hardness testers			

Measured Quantity & Range or Instrument	Expanded Measurement Uncertainty	Type of Service	Remarks
HR15T	Governed by the uncertainty of the	III	ASTM E18 Standardized Test
HR30T	standardized test block used to perform the indirect verification		Blocks per ASTM E18 See notes ⁴ , ⁷
HR15N			and $\frac{8}{2}$. On-site
HR30N			calibration available.

Indirect verification of Vickers and Knoop micro indentation hardness testers

Measured Quantity & Range or Instrument	Expanded Measurement Uncertainty	Type of Service	Remarks	
HK	Governed by the uncertainty of the standardized test block used to perform the indirect verification	III	ASTM E384 Standardized Test Blocks per ASTM E384 See notes ⁵ , ⁷ and ⁸ . On-site calibration available.	
Indirect verification of Vickers hardness testers				
HV	Governed by the uncertainty of the standardized test block used to perform the indirect verification	III	ASTM E92 Standardized Test Blocks per ASTM E92 See notes ⁶ , ⁷ and ⁸ . On-site calibration available.	

Measured Quantity & Range or Instrument	Expanded Measurement Uncertainty	Type of Service	Remarks	
Indirect verification of Rockwell and Vickers portable hardness testers				
HRC	Governed by the uncertainty of the standardized test block used to perform the indirect verification	III	ASTM E18 and E92 Standardized Test Blocks per ASTM E18 & E92	
HV			See notes $\frac{4}{6}$, $\frac{6}{7}$ and $\frac{8}{6}$. On-site calibration available.	

- The Calibration Measurement Capability (CMC) listed can be achieved only if the standards being calibrated are suitable for such a measurement. The uncertainty stated on a calibration report will reflect the uncertainty contribution of the standards that were calibrated.
- $\underline{2}$ This measured quantity is commonly known as parallelism of gauge blocks.
- The Calibration Measurement Capability listed is based on the calibration of an instrument with a resolution of 0.001 mm. The uncertainty stated on the calibration report will reflect the uncertainty contribution of the specific instrument that was calibrated.
- 4 The Indirect Verification of Rockwell Hardness Testers and Rockwell Superficial Hardness Testers is performed according to the requirements of ASTM E18.
- <u>5</u> The Indirect Verification of Knoop and Vickers Micro Hardness Testers is performed according to the requirements of ASTM E384.
- <u>6</u> The Indirect Verification of Vickers Hardness Testers is performed according to the requirements of ASTM E92.
- ASTM E18, E384 and E92 are published by the ASTM International (ASTM).
- The uncertainty of the hardness tester being calibrated is calculated for each specific test point and is dependant on the uncertainty of the specific hardness test block used and on the performance characteristics of the hardness tester itself.

- <u>9</u> The conformance to specification of the CMM is made in accordance with ISO 14253-1 taking into account all test measurement uncertainties.
- This CMC is obtained using a low expansion artefact being at least 66% of the longest spatial diagonal of the measuring volume of the CMM, and the shortest size being less that 30 mm, over a temperature ranging from 19.5 to 20.5°C.
- This CMC is obtained using a laser interferometer measuring technique, over a temperature ranging from 19.5 to 20.5°C.
- The reference sphere supplied with the CMM will not be used for this test.
- Calibrated in comparison with traceable standards using a Legex CMM.
- Calibrated in comparison with traceable standards using a roundness tester.
- <u>15</u> Calibrated using a Legex CMM.
- 16 ASME B46.1
- For imaging probe CMM capable of 3D and 2D measurements, using the component approach.

- <u>18</u> Limited to unidirectional measurements.
- <u>19</u> Calibrated in comparison with a master glass scale

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